



P-Channel 2.5-V (G-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$r_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ)		
-20	0.055 @ V _{GS} = -4.5 V	-5.3			
	0.06 @ V _{GS} = -3.6 V	-5.1	11		
	0.083 @ V _{GS} = -2.5 V	-4.3			

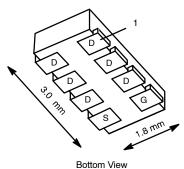
FEATURES

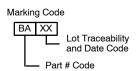
- TrenchFET® Power MOSFET
- 2.5-V Rated

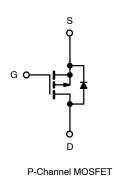


Pb-free Available

1206-8 ChipFET®







Ordering Information: Si5441DC

Si5441DC-T1-E3 (Lead (Pb)-Free)

ABSOLUTE MAXIMUM RATINGS (T _A = 25°C UNLESS OTHERWISE NOTED)						
Parameter		Symbol	5 secs	Steady State	Unit	
Drain-Source Voltage		V _{DS}	-20		V	
Gate-Source Voltage		V _{GS}	±12			
Continuous Drain Current (T,I = 150°C)a	T _A = 25°C	I _D	-5.3	-3.9	A	
Continuous Diam Current (1) = 150 C)	T _A = 85°C		-3.8	-2.8		
Pulsed Drain Current		I _{DM}	-20		^	
Continuous Source Current ^a		Is	-2.1	-1.1		
Maximum Power Dissipation ^a	T _A = 25°C	P _D	2.5	1.3	W	
	T _A = 85°C		1.3	0.7		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to 150		°C	
Soldering Recommendations (Peak Temperature)b, c			260		*C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
	$t \le 5 \text{ sec}$	_	40	50	°C/W	
Maximum Junction-to-Ambient ^a	Steady State	R _{thJA}	80	95		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	15	20		

Notes

- a. Surface Mounted on 1" x 1" FR4 Board.
- b. See Reliability Manual for profile. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

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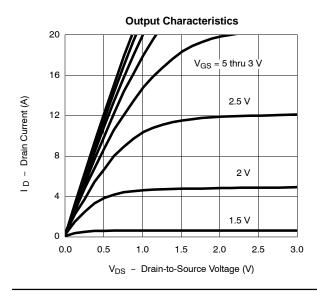
SPECIFICATIONS (T _J = 25°C UNLESS OTHERWISE NOTED)							
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
Static				1		•	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.6		-1.0	V	
Gate-Body Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±12 V			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^{\circ}\text{C}$			-1 -5	μΑ	
On-State Drain Currenta	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-20			Α	
		$V_{GS} = -4.5 \text{ V}, \ I_D = -3.9 \text{ A}$		0.046	0.055		
Drain-Source On-State Resistance ^a	r _{DS(on)}	$V_{GS} = -3.6 \text{ V}, I_D = -3.7 \text{ A}$		0.050	0.06	Ω	
		$V_{GS} = -2.5 \text{ V}, I_D = -3.1 \text{ A}$		0.070	0.083		
Forward Transconductancea	9fs	$V_{DS} = -10 \text{ V}, I_D = -3.9 \text{ A}$		12		S	
Diode Forward Voltage ^a	V_{SD}	I _S = -1.1 A, V _{GS} = 0 V		-0.8	-1.2	V	
Dynamic ^b							
Total Gate Charge	Qg			11	22	nC	
Gate-Source Charge	Q _{gs}	V_{DS} = -10 V, V_{GS} = -4.5 V, I_D = -3.9 A		3.0			
Gate-Drain Charge	Q_{gd}			2.5			
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = -10 V, R_L = 10 Ω		35	55	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 6 \Omega$		65	100		
Fall Time	t _f			45	70		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = -1.1 A, di/dt = 100 A/μs		30	60		

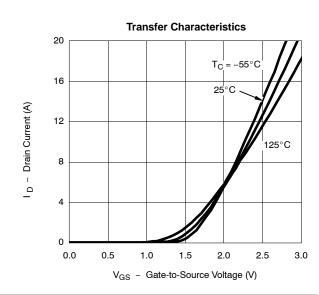
Notes

- Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2%.
- Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)







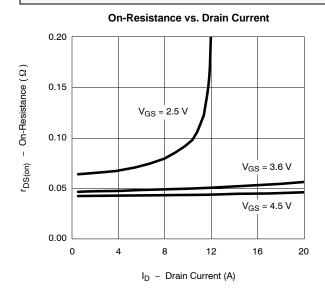




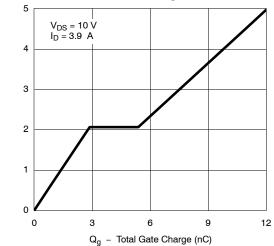
V_{GS} - Gate-to-Source Voltage (V)

Source Current (A)

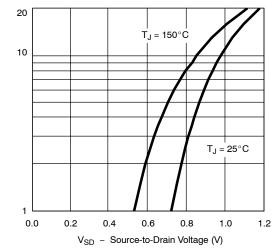
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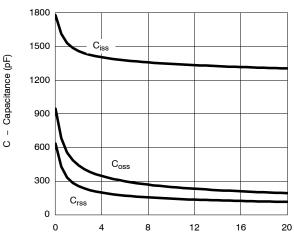




Source-Drain Diode Forward Voltage

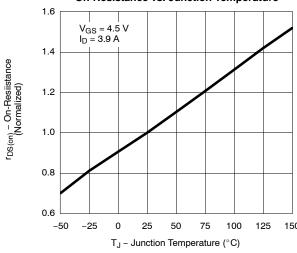


Capacitance

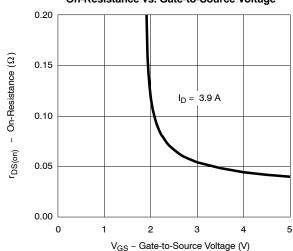


V_{DS} - Drain-to-Source Voltage (V)

On-Resistance vs. Junction Temperature



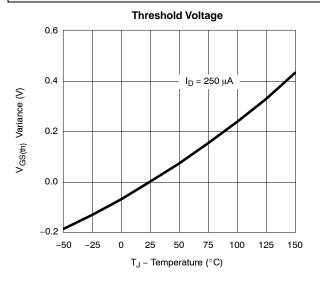
On-Resistance vs. Gate-to-Source Voltage

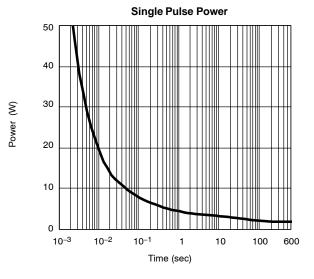


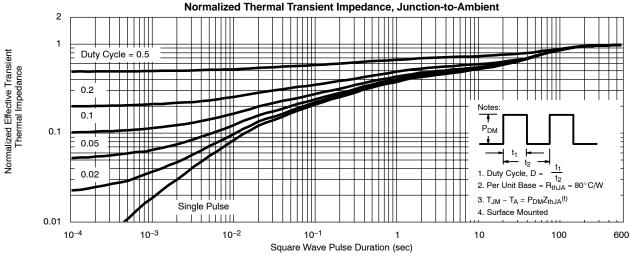
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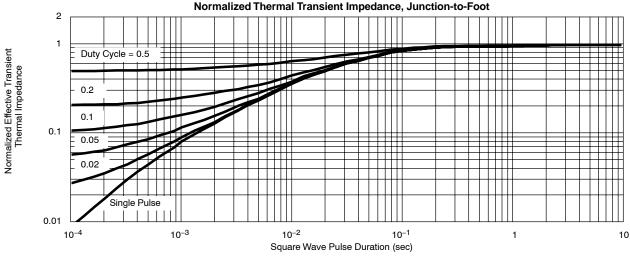


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